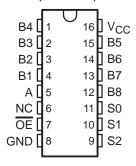
#### 5-Ω Switch Connection Between Two Ports

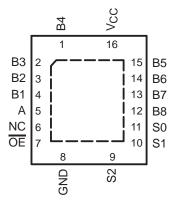
## D, DB, DBQ, OR PW PACKAGE (TOP VIEW)



NC - No internal connection

## TTL-Compatible Input Levels

#### RGY PACKAGE (TOP VIEW)



NC - No internal connection

## description/ordering information

The SN74CBT3251 is a 1-of-8 high-speed TTL-compatible FET multiplexer/demultiplexer. The low on-state resistance of the switch allows connections to be made with minimal propagation delay.

When output enable ( $\overline{OE}$ ) is low, the SN74CBT3251 is enabled. S0, S1, and S2 select one of the B outputs for the A-input data.

#### ORDERING INFORMATION

TA	PACKAGE <sup>†</sup>		ORDERABLE PART NUMBER	TOP-SIDE MARKING	
-40°C to 85°C	QFN – RGY	Tape and reel	SN74CBT3251RGYR	CU251	
	0010 D	Tube	SN74CBT3251D	CBT3251	
	SOIC - D	Tape and reel	SN74CBT3251DR		
	SSOP – DB	Tape and reel	SN74CBT3251DBR	CU251	
	SSOP (QSOP) – DBQ	Tape and reel	SN74CBT3251DBQR	CU251	
	TSSOP – PW	Tube	SN74CBT3251PW	CLIOT4	
		Tape and reel	SN74CBT3251PWR	CU251	

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



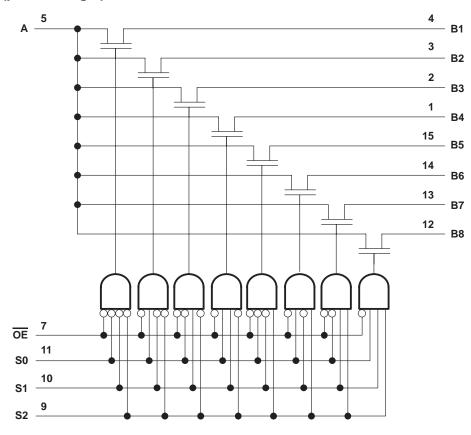
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FUNCTION TABLE (each multiplexer/demultiplexer)

	INP	FUNCTION		
OE	S2	S1	S0	FUNCTION
L	L	L	L	A port = B1 port
L	L	L	Н	A port = B2 port
L	L	Н	L	A port = B3 port
L	L	Н	Н	A port = B4 port
L	Н	L	L	A port = B5 port
L	Н	L	Н	A port = B6 port
L	Н	Н	L	A port = B7 port
L	Н	Н	Н	A port = B8 port
Н	Χ	Χ	X	Disconnect

## logic diagram (positive logic)



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## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V <sub>CC</sub> –	0.5 V to 7 V
Input voltage range, V <sub>I</sub> (see Note 1) –	0.5 V to 7 V
Continuous channel current	128 mA
Input clamp current, $I_K (V_{I/O} < 0)$	–50 mA
Package thermal impedance, θ <sub>JA</sub> (see Note 2): D package	73°C/W
(see Note 2): DB package	82°C/W
(see Note 2): DBQ package	90°C/W
(see Note 2): PW package	108°C/W
(see Note 3): RGY package	39°C/W
Storage temperature range, T <sub>stq</sub> –65	°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- 2. The package thermal impedance is calculated in accordance with JESD 51-7.
- 3. The package thermal impedance is calculated in accordance with JESD 51-5.

### recommended operating conditions (see Note 4)

		MIN	MAX	UNIT
Vcc	Supply voltage	4	5.5	V
VIH	High-level control input voltage	2		V
VIL	Low-level control input voltage		8.0	V
TA	Operating free-air temperature	-40	85	°C

NOTE 4: All unused control inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP‡	MAX	UNIT	
VIK		$V_{CC} = 4.5 \text{ V},$	$I_{ } = -18 \text{ mA}$				-1.2	V
II		V <sub>C</sub> C = 5.5 V,	$V_I = 5.5 \text{ V or GND}$				±1	μΑ
Icc		$V_{CC} = 5.5 \text{ V},$	I <sub>O</sub> = 0,	$V_I = V_{CC}$ or GND			3	μΑ
∆ICC§	Control inputs	$V_{CC} = 5.5 \text{ V},$	One input at 3.4 V,	Other inputs at V <sub>CC</sub> or GND			2.5	mA
Ci	Control inputs	V <sub>I</sub> = 3 V or 0				3.5		pF
	A port	V 0V 0	<del>OE</del> = V <sub>CC</sub>			17.5		
C <sub>io(OFF)</sub>	B port	$V_{O} = 3 \text{ V or } 0,$				4		pF
r <sub>on</sub> ¶		$V_{CC} = 4 \text{ V},$ TYP at $V_{CC} = 4 \text{ V}$	V <sub>I</sub> = 2.4 V,	I <sub>I</sub> = 15 mA		14	20	
			., .	I <sub>I</sub> = 64 mA		5	7	Ω
		$V_{CC} = 4.5 \text{ V}$ $V_{I} = 0$ $V_{I} = 2.4 \text{ V}$	V  = U	I <sub>I</sub> = 30 mA		5	7	
			V <sub>I</sub> = 2.4 V,	I <sub>I</sub> = 15 mA		10	15	]

<sup>‡</sup> All typical values are at  $V_{CC}$  = 5 V (unless otherwise noted),  $T_A$  = 25°C.



NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

<sup>§</sup> This is the increase in supply current for each input that is at the specified TTL voltage level, rather than V<sub>CC</sub> or GND.

Measured by the voltage drop between the A and the B terminals at the indicated current through the switch. On-state resistance is determined by the lower of the voltages of the two (A or B) terminals.

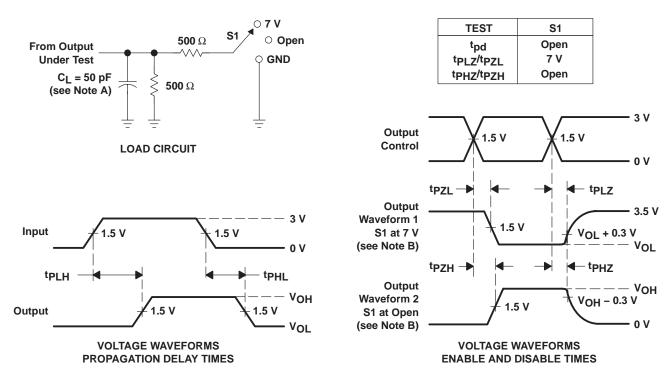
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## switching characteristics over recommended operating free-air temperature range, $C_L$ = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	TO	V <sub>CC</sub> = 4 V	V <sub>CC</sub>	V <sub>CC</sub> = 5 V ± 0.5 V	
	(INPUT)	(OUTPUT)	MIN MAX	MIN	MAX	
t <sub>pd</sub> †	A or B	B or A	0.35		0.25	ns
t <sub>pd</sub>	S	А	6	2	5.5	ns
	S	В	6.4	1.5	5.6	ns
t <sub>en</sub>	ŌĒ	A or B	6.4	1.6	5.8	
	S	В	6.8	1.9	6.4	
<sup>t</sup> dis	ŌĒ	A or B	6	2.3	6.2	ns

<sup>&</sup>lt;sup>†</sup> The propagation delay is the calculated RC time constant of the typical on-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).

#### PARAMETER MEASUREMENT INFORMATION

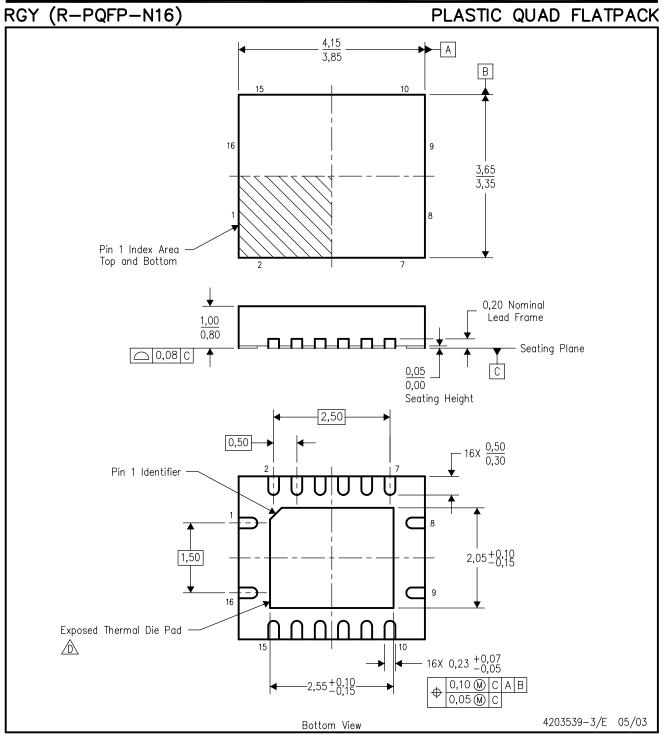


NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>f</sub>  $\leq$  2.5 ns, t<sub>f</sub>  $\leq$  2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. tpLZ and tpHZ are the same as tdis.
- F. tpzL and tpzH are the same as ten.
- G. tpLH and tpHL are the same as tpd.
- H. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. QFN (Quad Flatpack No-Lead) package configuration.
- The package thermal performance may be enhanced by bonding the thermal die pad to an external thermal plane.

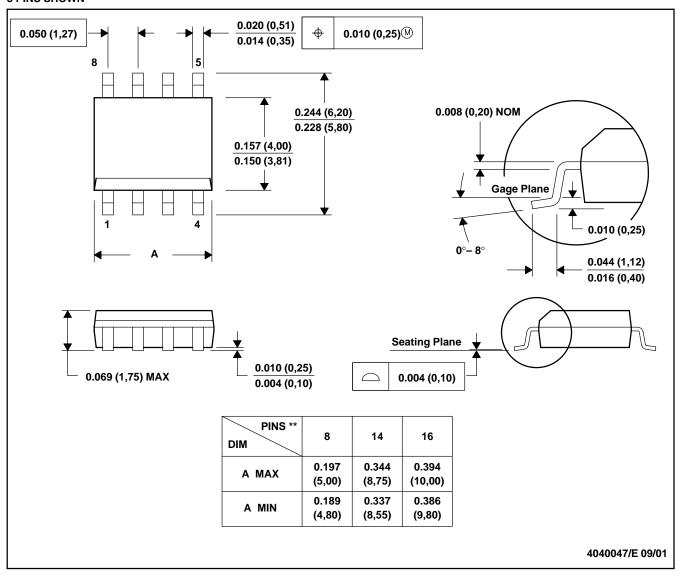
  This pad is electrically and thermally connected to the backside of the die and possibly selected ground leads.
  - E. Package complies to JEDEC MO-241 variation BB.



#### D (R-PDSO-G\*\*)

#### PLASTIC SMALL-OUTLINE PACKAGE

#### **8 PINS SHOWN**



NOTES: A. All linear dimensions are in inches (millimeters).

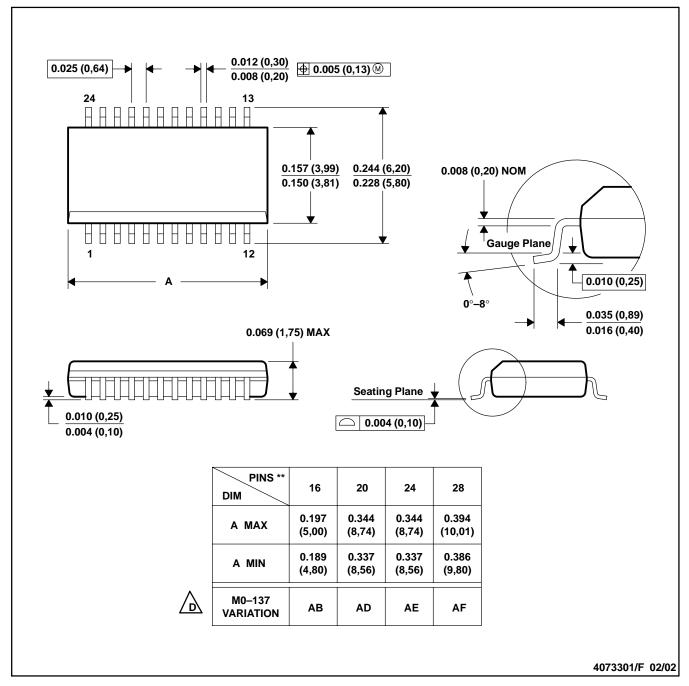
B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-012

#### DBQ (R-PDSO-G\*\*)

#### PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MO-137.



## DB (R-PDSO-G\*\*)

## PLASTIC SMALL-OUTLINE

#### **28 PINS SHOWN**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-150

## PW (R-PDSO-G\*\*)

#### 14 PINS SHOWN

## PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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